

**AMENDMENTS TO THE CLAIMS**

Claims 1-21. (Cancelled)

22. (Currently Amended) A semiconductor device comprising:

a semiconductor chip;

at least a first electrode formed on a first major surface of said semiconductor chip;

at least a second electrode formed on a second major surface of said semiconductor chip  
opposite to said first major surface;

at least a conductive member connecting said first electrode to said second electrode and  
covering a side surface of said semiconductor chip; and

a conductive line pattern formed on said second major surface and extending from said  
second electrode, wherein said conductive line pattern is separate from said conductive member.

23. (Previously Presented) A composite semiconductor device structure, comprising at  
least two semiconductor devices, wherein

each of said semiconductor devices include:

a semiconductor chip;

at least a first electrode formed on a first major surface of said semiconductor  
chip;

at least a second electrode formed on a second major surface of said  
semiconductor chip opposite to said first major surface;

at least a conductive member connecting said first electrode to said second electrode and covering a side surface of said semiconductor chip;  
said at least two semiconductor devices are stacked on each other, and  
a conductive member of a lower one of said semiconductor devices is directly connected to a conductive member of an upper one of said semiconductor devices.

24. (Currently Amended) A composite semiconductor device structure, comprising at least two semiconductor devices, wherein

each of said semiconductor devices include:  
a semiconductor chip;  
at least a first electrode formed on a first major surface of said semiconductor chip;  
an insulating layer formed on a second major surface of said semiconductor chip opposite to said first major surface;  
~~at least a second electrode formed on said insulating layer;~~  
at least a conductive member connected to ~~connecting~~ said first electrode ~~to said second electrode~~ and covering a side surface of said semiconductor chip;  
said at least two semiconductor devices are stacked on each other, and  
a conductive member of a lower one of said semiconductor devices is directly connected to a conductive member of an upper one of said semiconductor devices.

25. (Previously Presented) A composite semiconductor device structure, comprising at least two semiconductor devices as defined in claim 22, wherein  
said at least two semiconductor devices are stacked on each other, and

a conductive line pattern extending from a first electrode on a first major surface of a lower one of said semiconductor devices is connected via a bump to a conductive line pattern extending from a second electrode on a second major surface of an upper one of said semiconductor devices.

Claim 26. (Cancelled)